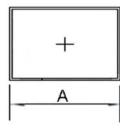
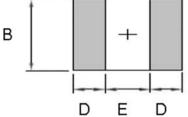


### **FEATRLRES**

- This specification applies Low Profile Power Inductors.
- 100% Lead(Pb) & Halogen-Free and RoHS compliant.

## CONFIGRLRATIONS & DIMENSIONS ( unit in mm )







Туре	Α	В	С	D	E
HNR252008MF	2.50-0.1/+0.3	2.0-0.05/+0.35	0.80 max.	0.85 ref.	0.80 ref.

## **ELECTRICAL CHARACTERISTICS**

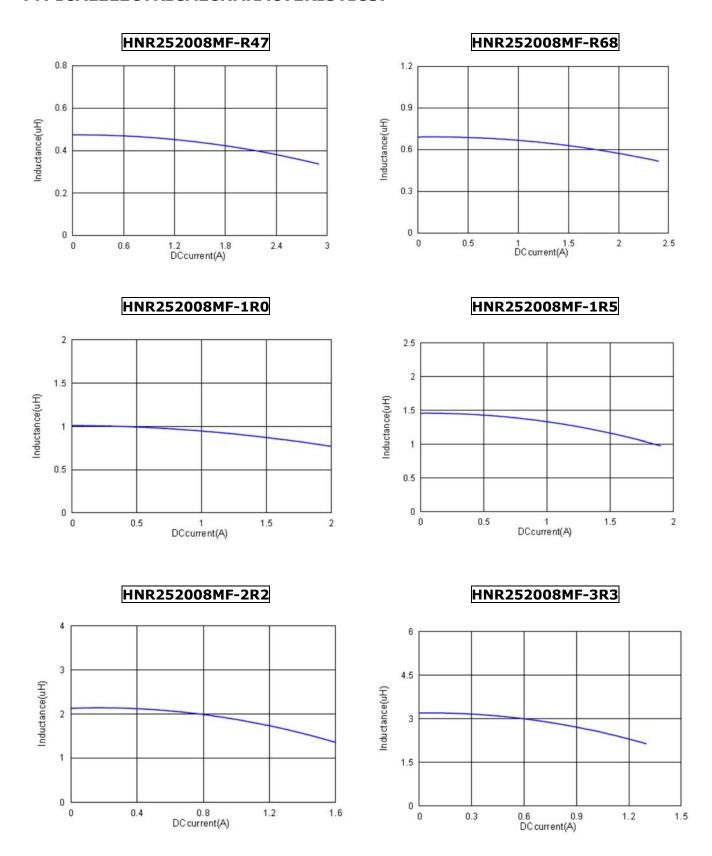
Part Number	Inductance	e Tolerance	Test Frequency	DCR	I sat (A)	I sat (A)	I rms (A)	I rms (A)
	(uH)	(%)	(Hz)	(Ω) ±20%	typ.	max.	typ.	max.
HNR252008MF-R47M	1 0.47	±20%	0.1V/1M	0.080	0.096	2.50	2.20	1.45
HNR252008MF-R68M	0.68	±20%	0.1V/1M	0.100	0.120	2.05	1.80	1.35
HNR252008MF-1R0M	1 1.0	±20%	0.1V/1M	0.120	0.145	1.75	1.50	1.20
HNR252008MF-1R5M	1 1.5	±20%	0.1V/1M	0.170	0.200	1.65	1.45	1.05
HNR252008MF-2R2M	1 2.2	±20%	0.1V/1M	0.210	0.250	1.40	1.20	0.95
HNR252008MF-3R3M	1 3.3	±20%	0.1V/1M	0.300	0.360	1.10	0.95	0.85
HNR252008MF-4R7M	4.7	±20%	0.1V/1M	0.400	0.480	0.90	0.80	0.70
HNR252008MF-6R8M	1 6.8	±20%	0.1V/1M	0.670	0.800	0.75	0.65	0.55
HNR252008MF-100M	1 10.0	±20%	0.1V/1M	0.930	1.110	0.55	0.50	0.45

Note:

Isat : Based on inductance change  $( \triangle L/L0 : \leq -30\%)$  @ ambient temp.  $25^{\circ}$ C

Irms : Based on temperature rise  $( \triangle T : 40^{\circ}C \text{ typ.} )$ 

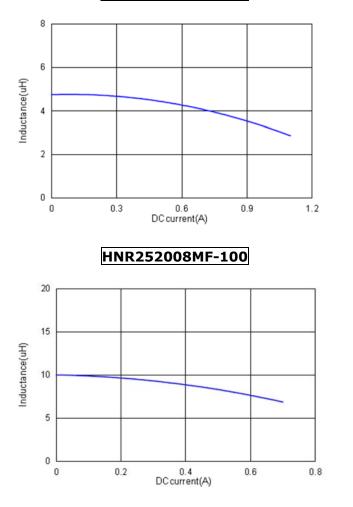








#### HNR252008MF-4R7



# **Reliability and Test Condition**

Item	Performance	Test Condition		
Operating temperature	-40~+125°C (Including self - temperature rise)			
Storage temperature	110~+40℃,50~60%RH (Product with taping) 240~+125℃ (on board)			
Electrical Performance Test				
Inductance	Refer to standard electrical characteristics list.	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.		
DCR	Refer to standard electrical characteristics list.	CH16502,Agilent33420A Micro-Ohm Meter.		
Saturation Current (Isat)	Approximately∆L30%	Saturation DC Current (Isat) will cause L0 to drop		
Heat Rated Current (Irms)	Approximately △T40℃	Heat Rated Current (Irms) will cause the coil temperature rise $\triangle T(^{\circ}C)$ . 1.Applied the allowed DC current 2.Temperature measured by digital surface thermometer		
Reliability Test				
Life Test		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020DClassification Reflow Profiles) Temperature : 125±2°C (Inductor) Applied current : rated current		
	Appearance : No damage.	Duration : 1000±12hrs Measured at room temperature after placing for 24±2 hrs		

HNR252008MF-6R8

## HSIA TECHNOLOGY CO.LTD. TEL:886-2-2999-6691 FAX: 2999-6692 Website:www.hsia.com.tw



	Inductance : within±10% of initial value	Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020DClassification Reflow Profiles
Load Humidity	Q : Shall not exceed the specification value.	Humidity : 85±2 * R.H.
	RDC:within ±15% of initial value and shall not	Temperature : 85°C ±2°C
	exceed the specification value	Duration : 1000hrs Min. with 100% rated current
		Measured at room temperature after placing for 24±2 hrs
Moisture Resistance		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD-020DClassification Reflow Profiles 1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to $65\pm2°C$ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to $25°C$ in 2.5hrs. 3. Raise temperature to $65\pm2°C$ 90-100%RH in 2.5hrs, and keep 3 hours, cool down to $25°C$ in 2.5hrs,keep at $25°C$ for 2 hrs then keep at $-10°C$ for 3 hrs 4. Keep at $25°C$ 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for $1\sim2$ hrs.
Thermal shock		Preconditioning: Run through IR reflow for 2 times.( IPC/JEDEC J-STD- 020DClassification Reflow Profiles Condition for 1 cycle Step1: $-40\pm2$ °C 30 $\pm$ 5min Step2: $25\pm2$ °C $\leq$ 0.5min Step3: $125\pm2$ °C 30 $\pm$ 5min Number of cycles: 500 Measured at room temperature after placing for 24 $\pm$ 2 hrs
Vibration		Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes Equipment : Vibration checker Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations).
Bending		Shall be mounted on a FR4 substrate of the following dimensions: >=0805 inch(2012mm):40x100x1.2mm <0805 inch(2012mm):40x100x0.8mm Bending depth: >=0805 inch(2012mm):1.2mm <0805 inch(2012mm):0.8mm duration of 10 sec.
Shock	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	TypePeak value (g's)Normal duration (D)Wave formVelocity change (Vi)ft/secSMD5011Half-sine11.3Lead5011Half-sine11.3
Solder ability	More than 95% of the terminal electrode should be covered with solder。	Preheat: 150°C,60sec.₀ Solder: Sn96.5% Ag3% Cu0.5% Temperature: 245±5°C ∘ Flux for lead free: Rosin. 9.5% ∘ Dip time: 4±1sec ∘ Depth: completely cover the termination
Resistance to Soldering Heat		Depth: completely cover the termination   Temperature(°C) Time(s) Temperature ramp/immersion and emersion rate Number of heat cycles   260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s 1
Terminal Strength	Appearance : No damage. Impedance : within±15% of initial value Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value e	Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD- 020DClassification Reflow Profiles With the component mounted on a PCB with the device to be tested, apply a force(>0805:1Kg, <=0805:0.5Kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested.

Note : When there are questions concerning measurement result : measurement shall be made after 48 ± 2 hours of recovery under the standard condition.